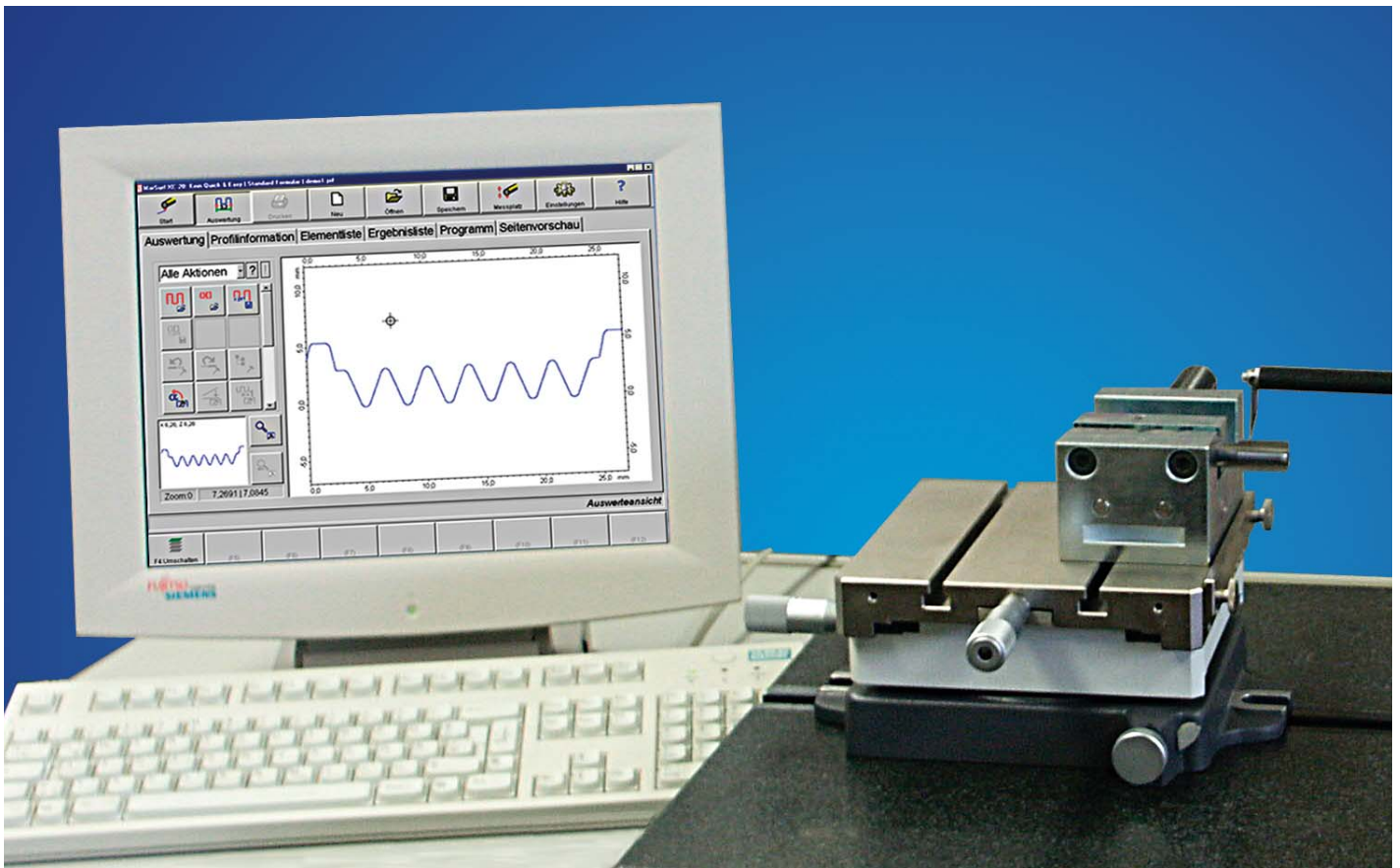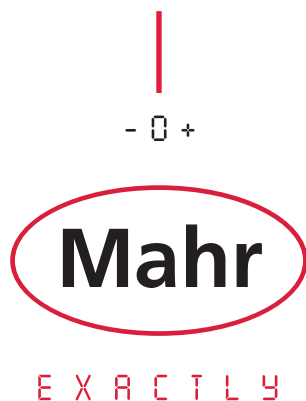# M a r S u r f

MarSurf XC 20
offers increased and a new user interface for your step into the new generation of contour metrology
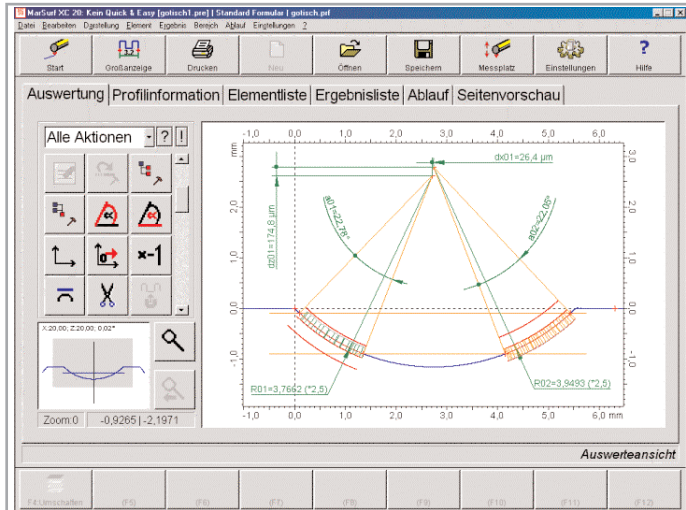
With this system you obtain a state-of-the-art contour measuring station which requires hardly any training and is tailor-made for each user. - You reduce costs and increase safety of your processes.

Self-explanatory user interface:

• Interactive operation

• Different user levels

• Programmable evaluation

• Quick&Easy functionality via function keys

• Touchscreen operation as an option

– 0 +

Mahr

E X A C T L Y

MarSurf XC 20

Self-explanatory operation, as already known from MarSurf XR 20, i.e. two measuring disciplines presenting the same appearance. This gives your personnel safety and saves you time and money!

New functional characteristics:

- The zoom range can be moved within the overview field. You reach your evaluation section directly in the shortest possible time.
  - There is no quicker way!

- Multiple nominal profiles:
  Several nominal profiles can be loaded within a series of measurements, making laborious single measuring series superflous.
  - You couldn't do it any faster!

- Nominal profile parameterization:
  Partial sections of a contour can be parameterized differently for nominal profile fit-in. Only the relevant sectors are considered for the evaluation.
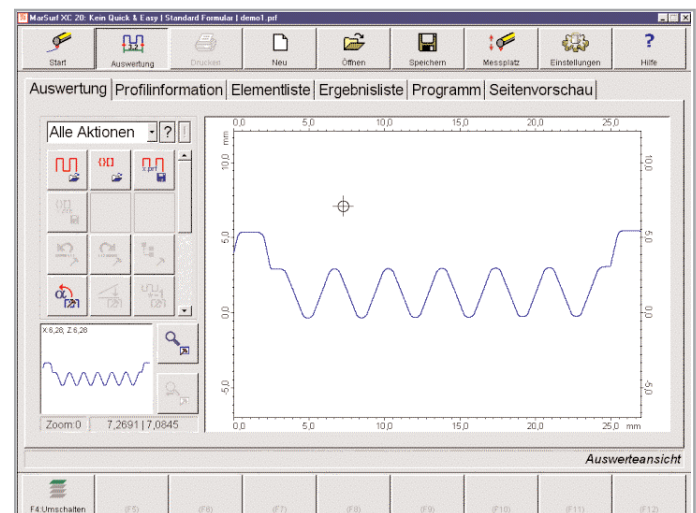 - There is nothing more precise!

- Configurable action/tool box:
  You only apply what you need for work.
  - Keep it as simple as possible!

- Associative elements:
  Re-calculation of correlated elements after changing the basic elements. Evaluations are actualized according to respective modifications, thus aroiding double steps.
  - Save your expensive time!